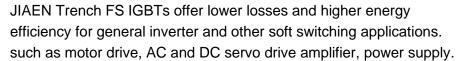


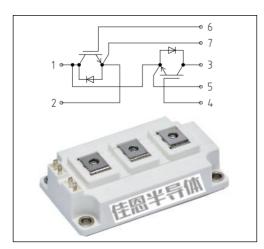
IGBT 62mm 半桥模块

Features

- 1200V 300A
- $V_{CE(sat)(typ.)}$ = 1.6V @ V_{GE} = 15V, I_{C} = 300A
- Soft turn off
- Positive VCE(on) Temperature Coefficient
- Easy paralleling







IGBT Maximum Rated Values

Symbol	Parameter	Value	Units
Vces	Collector-Emitter Voltage	1200	V
V _{GES}	Gate-Emitter Voltage	<u>+</u> 20	V
lc	Continuous Collector Current (T _C =70°C,T _{vj max} =150°C)	300	А
I _{CRM}	Repetitive Peak Collector Current (tp= 1 ms)	600	А
PD	Maximum Power Dissipation (T _C =25 °C,T _{vj max} =150 °C)	1344	W

IGBT Characteristics

Symbol	Parameter	Test Condition	Min	Тур	Max	Units
$V_{CE(sat)}$	Collector-Emitter Saturation Voltage	V_{GE} =15V, I_{C} =300A T_{Vj} =25°C	-	1.6	1.9	V
	Collector-Emitter Saturation Voltage	V_{GE} =15V, I_{C} =300A T_{vj} =150°C	-	1.9	-	V
V _{GE(th)}	Gate Threshold Voltage	$V_{GE}=V_{CE}$, $I_{C}=11.4$ mA	5.0	5.8	6.6	V
Qg	Total Gate Charge	V _{GE} =-15V+15V	-	2.03		uC
C _{ies}	Input Capacitance	V _{CE} =25V V _{GE} =0V f=100KHz	-	59.2	-	nF
C _{oes}	Output Capacitance		-	1.55	-	nF
C _{res}	Reverse Transfer Capacitance		-	0.46	-	nF
I _{CES}	Collector-Emitter Leakage Current	V _{CE} =1200V, V _{GE} =0V	-	-	2.0	mA
ī	Gate Leakage Current, Forward	V_{GE} =20V, V_{CE} =0V	-	-	200	nA
I _{GES}	Gate Leakage Current, Reverse	V _{GE} =-20V, V _{CE} =0V	-	-	-200	nA



t d(on)	Turn-on Delay Time		-	163	-	ns
t r	Turn-on Rise Time	Vcc=600V V _{GE=±} 15V	-	114	-	ns
t d(off)	Turn-off Delay Time		-	522	-	ns
t f	Turn-off Fall Time	I _C =300A R _G =3Ω	-	168	-	ns
Eon	Turn-on Switching Loss	Inductive Load	-	14.2	-	mJ
Eoff	Turn-off Switching Loss	T _{vj} =25 ℃	-	29.1	-	mJ
Ets	Total Switching Loss		-	43.3	-	mJ
t d(on)	Turn-on Delay Time		-	175	-	ns
t r	Turn-on Rise Time	Vcc=600V	-	122	-	ns
t d(off)	Turn-off Delay Time	V _{GE} =±15V	-	574	-	ns
t f	Turn-off Fall Time	Ic=300A R _G =3 Ω Inductive Load T _{vj} =125 $^{\circ}$ C	-	259	-	ns
Eon	Turn-on Switching Loss		-	22.7	-	mJ
Eoff	Turn-off Switching Loss		-	36.8	-	mJ
Ets	Total Switching Loss		-	59.5	-	mJ
t _{d(on)}	Turn-on Delay Time		-	176	-	ns
t r	Turn-on Rise Time	Vcc=600V	-	125	-	ns
t d(off)	Turn-off Delay Time	V _{GE} =±15V	-	587	-	ns
t f	Turn-off Fall Time	Ic=300A R _G =3Ω	-	291	-	ns
Eon	Turn-on Switching Loss	Inductive Load	-	23.5	-	mJ
Eoff	Turn-off Switching Loss	T _{vj} =150 ℃	-	39.0	-	mJ
Ets	Total Switching Loss		-	62.5	-	mJ
Isc	Short circuit current	$V_{GE}=15V$, $Tp \leqslant 10us$ $T_{vj}=150^{\circ}C$, $Vcc=600V$ $V_{CEM\ Chip} \leqslant 1200V$	-	1000	-	А
R _{th j-c}	Thermal resistance, junction to case		-	-	0.093	K/W
T _{vj op}	Temperature under switching condition		-40	-	150	$^{\circ}$



Diode Maximum Rated Values

Symbol	Parameter	Value	Units
V _{RRM}	Repetitive peak reverse voltage	1200	V
l _F	Continuous DC Forward Current	300	А
I _{FRM}	Repetitive Peak Collector Current (tp= 1ms)	600	А

Diode Characteristics

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
V_{F}	Distriction of the second	I _F =300A V _{GE} =0V T _{vj} =25℃	-	2.7	3.2	V
	Diode Forward Voltage	I _F =300A V _{GE} =0V T _{vj} =150℃	-	1.9	-	V
I _{RM}	Peak reverse recovery current	Ic=300A V _R =600V	-	112	1	Α
Q _{rr}	Diode Reverse Recovery Charge	-di/dt=2500A/us	-	8.7	-	uC
E _{rec}	Reverse recovery energy	$V_{GE=\pm 15V} T_{vj}=25^{\circ}C$	-	6.7	-	mJ
I _{RM}	Peak reverse recovery current	IC=300A VR=600V -di/dt=2500A/us V _{GE} =±15V T _{vj} =125°C	-	191	-	Α
Q _{rr}	Diode Reverse Recovery Charge		-	26.1	-	uC
E _{rec}	Reverse recovery energy		-	13.5	-	mJ
I _{RM}	Peak reverse recovery current	I _C =300A V _R =600V -di/dt=2500A/us V _{GE} =±15V T _{vj} =150℃	-	215	-	Α
Q _{rr}	Diode Reverse Recovery Charge		-	32.7	-	uC
E _{rec}	Reverse recovery energy		-	15.6	-	mJ
R _{th j-c}	Thermal resistance, junction to case		-	-	0.15	K/W
T _{vj op}	Temperature under switching condition		-40	-	150	$^{\circ}$

Module

Isolation test voltage	RMS, f=50 Hz, t=1 min	VISOL	4.0	kV
Material of module baseplate			Cu	
Internal isolation	basic insulation (class 1, IEC 61140)		Al ₂ O ₃	
Clearance distance in air	Terminal to terminal		10	mm
Surface creepage distance	Terminal to terminal		13	mm
Comperative tracking index		CTI	>200	
Storage temperature		Tstg	-40~150	$^{\circ}$
Mounting torque for module mounting	M6 screws	М	3~6	Nm

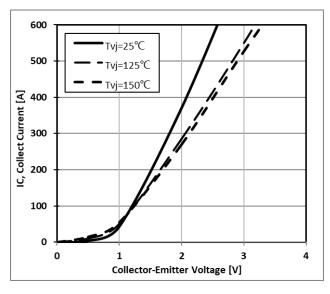
Notes:

^{1.} Repetitive Rating: Pulse width limited by maximum junction temperature





Typical Performance Characteristics



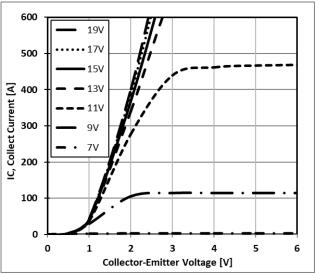
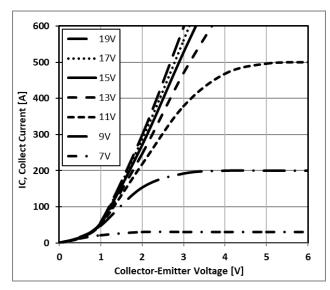
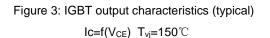


Figure 1: IGBT output characteristics (typical) $Ic=f(V_{CE})$ $V_{GE}=15V$

Figure 2: IGBT output characteristics (typical) Ic=f(V_{CE}) T_{vi} =25 $^{\circ}$ C





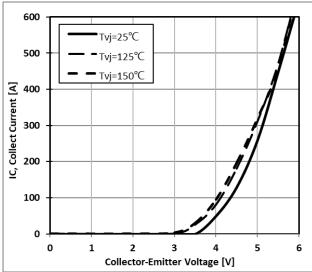
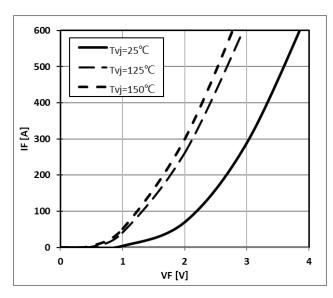


Figure 4: IGBT transfer characteristics (typical)

Ic=f(V_{GE}) V_{CE}=V_{GE}





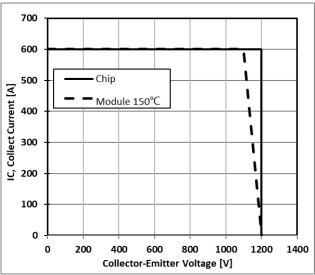
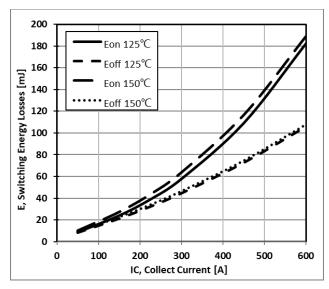


Figure 5: Diode forward characteristic (typical) $I_F \! = \! f(V_F)$

Figure 6: IGBT RBSOA $\label{eq:central_continuous} \text{Ic=f(V}_{\text{CEm}}) \ \ \text{Rgoff=8} \ {}^{\Omega} \, , \, \text{V}_{\text{GE}}\text{=}\pm 15\text{V}$



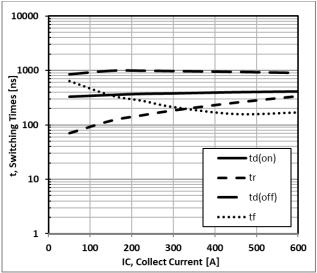


Figure 7: IGBT switching losses (typical) $E=f(I_{CE})$ $V_{CE}=600V,~R_{Gon}=8~\Omega~,~R_{Goff}=8~\Omega~,~V_{GE}=\pm~15V$



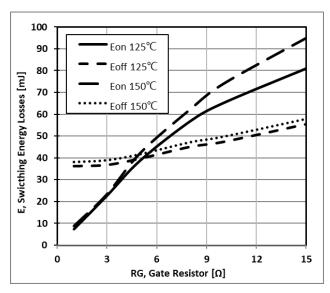
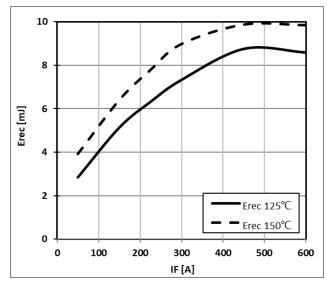


Figure 9: IGBT switching losses (typical) $E=f(R_G)$ $V_{CE}=600V,\ IC=300A,\ V_{GE}=\pm\,15V$

Figure 10: IGBT switching times (typical) $t=f(R_G) \ T_{Vj}=150\,^{\circ}\text{C}$ $V_{\text{CE}}=600\text{V}, \text{IC}=300\text{A}, \text{V}_{\text{GE}}=\pm\,15\text{V}$



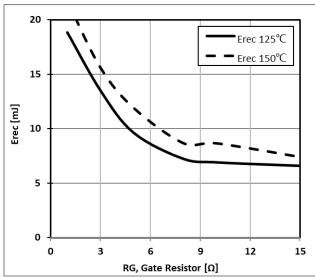
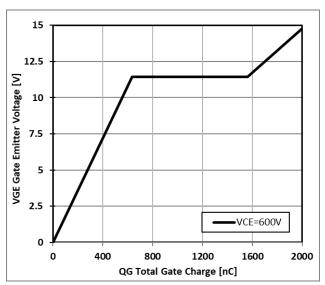
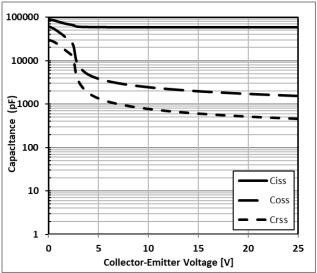


Figure 11: Diode switching characteristics (typical) $E_{REC} = f(I_F)$ $V_{DC} = 600V, \ R_{Gon} = 8 \ \Omega \ (IGBT), \ V_{GE} = \pm \ 15V(IGBT)$

Figure 12: Diode switching characteristics (typical) $E_{REC} = f(R_G)$ $V_{DC} = 600V, \ I_F = 300A, \ V_{GE} = \pm 15V(IGBT)$

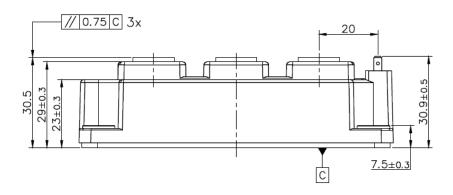


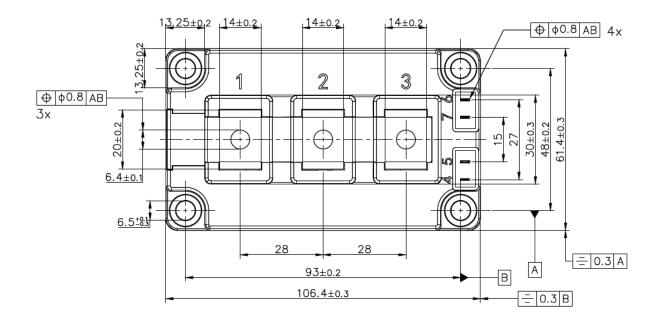


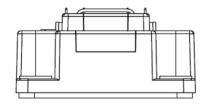




Mechanical Dimensions









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